APPLICA	ABLE STAN		Note deleted									
	Operating Ten Range		-25°C to +105°C ⁽²⁾		Sto	rage Temperature Range			-10°C to +60°C			
Rating	Voltag	e	AC 1000V , DC 15	00V	-			-				
	Currer					applicable Cable 200mm² (400MCM)						
		T	SPEC	CIFICAT	IONS	<u>S</u>				1	1	
	TEM RUCTION		TEST METHOD				RI	EQU	IREMENTS	QT	A ⁻	
General Ex		Examined	visually and with a measu	ring instrum	nent.	A	San ta tha	.l		Х	Х	
Marking		Confirmed				Accora	ing to the	arav	ving.	Χ	Х	
ELECTR	ICAL CHAR	ACTERI	STICS									
Contact Resistance		Measured at DC 1A.				0.1mΩ MAX.				Х	-	
Insulation Resistance		Measured at DC 500V.				1000MΩ MIN.				Х	_	
Voltage Proof		AC 5000V applied for 1min.(JIS C 8201)			No flashover or breakdown.				Х	_		
Short-Time Withstand Current Test		Measured at 24000A applied for 1s.(JIS C 8201)				Contact Resistance: 0.15 mΩ MAX.				Х	_	
	VICAL CHAP	RACTER	ISTICS							ı		
Crimp Contact Insertion and Extraction Forces		Measured with an applicable connector.				Insertion Force: 280N MAX. Extraction Force: 250N MAX.				Х	_	
Mechanical Operation		Contact Inserted and Extracted 50 times.			 No function impairing damage, cracks, or looseness of parts. Contact Resistance: 0.15mΩ MAX. Insertion Force: 280N MAX. Extraction Force: 250N MAX. 				х	_		
Vibration		Frequency: 10 Hz to 55 Hz Single amplitude: 0.75 mm Performed two hours in each of three mutually perpendicular directions. (MIL-STD-1344 Method 2005, Condition 2)				 No electrical disconuity of 10µs. No damage, cracks, or looseness of parts. 				х	_	
Shock		Acceleration: 500 m/s ² Half sine wave pulses of 11 ms. Performed five times both ways in each of three mutually perpendicular directions.								x	_	
Contact Retention Force		A 578N pulling force was applied to the connection side. (NECA C 2811) /2				No damage.				Х	_	
ENVIRO	NMENTAL (CHARAC	TERISTICS									
Damp Heat (Steady State)		96 hours. Returned to room temperature and normal			 Insulation Resistance: 20MΩ MIN. Voltage Proof: AC 5000V applied for 1min. No flashover or breakdown. No damage, cracks, or looseness of parts. 				x	_		
Heat and Cold Resistance		Subjected to -25±3°C for 2 hours. Returned to room temperature for 1 hour. Subjected to 70±3°C for 2 hours. (NECA C 2811)			 Insulation Resistance: 20MΩ MIN. Voltage Proof: AC 5000V applied for 1min. No flashover or breakdown. No damage, cracks, or looseness of parts. 				x	_		
Ageing Test		Subjected to the following cycle 192 times with 370A applied. Subjected to 40±3°C for 10 minutes, cooled to 30°C and left for 10 minutes. (JIS C 8201)				 Contact Resistance: 0.15mΩ MAX. No damage, cracks, or looseness of parts. 					_	
COU	NT DE	SCRIPTION	N OF REVISIONS		DESIG				CHECKED		TE	
3 1		DIS-C-00017593			HR. S	ATO			KI. NAGANUMA	2024052		
Notes	Ab 20		only to a second of the second				APPRO\	/ED	TP. KOMATSU	2020	030	
(1)	applicable crimp	ons show the values in assembled condition with contacts. ature rise caused by current carrying.				CHECKED TP. KOMATSU		TP. KOMATSU	20200227			
\ _ /					DESIGNED		IED	EK. KIDO	20200226			
Unless othe	erwise specified,	, refer to IEC 60512 (JIS C 5402).				DRA		'N	EK. KIDO		20200226	
	Qualification Tes	st AT:Assurance Test X:Applicable Test			DRAWIN		G NO. ELC-385257-00-)	
Note Q1:0					PART N		NO. EF2A-D400B-		FF04 D400D 4			
HS	SF	PECIFIC	CATION SHEET		PART	NO.				A	1/1	